



## **Dual SPDT Analog Switch**

#### **DESCRIPTION**

The DG9636 is a CMOS, dual SPDT analog switch designed to operate from 2.7 V to 12 V, single supply. All control logic inputs have a guaranteed 1.65 V logic HIGH threshold when operation from a 12 V power supply. This makes the DG9636 ideally suited to interface directly with low voltage micro-processor control signals.

Processed with high density CMOS technology, the DG9636 has a 83  $\Omega$  channel ON resistance while providing ultra low parasitic capacitance of 2 pF for CS<sub>(off)</sub> and 7 pF for CD<sub>(on)</sub>. Other performance features are: 720 MHz -3 dB bandwidth, -67 dB Cross Talk and -58 dB Off isolation at 10 MHz frequency.

Key applications for the DG9636 are logic level translation, pulse generator, and high speed or low noise signal switching in precision instrumentations and portable device designs.

The DG9636 is available in space saving 1.4 mm x 1.8 mm miniQFN10 package.

As a committed partner to the community and the environment, Vishay Siliconix manufactures this product with lead (Pb)-free device termination. The miniQFN-10 package has a nickel-palladium-gold device termination and is represented by the lead (Pb)-free "-E4" suffix to the ordering part number. The nickel-palladium-gold device terminations meet all JEDEC® standards for reflow and MSL rating.

#### **FEATURES**

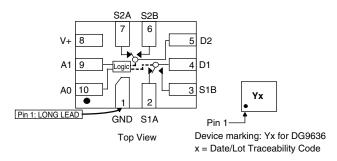
- Leakage current < 0.5 nA max. at 85 °C</li>
- Low switch capacitance (C<sub>soff</sub>, 2 pF typ.)
- R<sub>DS(on)</sub> -83 Ω max.
- Low voltage, 1.65 V CMOS/TTL compatible
- 720 MHz, -3 dB bandwidth
- Fully specified with single supply operation at 12 V
- Excellent isolation and crosstalk performance (typ. > -60 dB at 10 MHz)
- Fully specified from -40 °C to 85 °C and -40 °C to +125 °C
- Latch-up current 300 mA per JESD78
- Lead (Pb)-free low profile miniQFN-10 (1.4 mm x 1.8 mm x 0.55 mm)
- Material categorization: For definitions of compliance please see <a href="https://www.vishav.com/doc?99912"><u>www.vishav.com/doc?99912</u></a>

#### **APPLICATIONS**

- · High-end data acquisition
- Medical instruments
- · Precision instruments
- High speed communications applications
- Automated test equipment
- Sample and hold applications

## **FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION**

#### DG9636 miniQFN - 10L



TRUTH TABLE	TRUTH TABLE									
Selec	ted Input	On Switches								
A1	Α0	DG9636								
Х	0	D1 to S1A								
Х	1	D1 to S1B								
0	X	D2 to S2A								
1	X	D2 to S2B								





ORDERING INFORMAT	ORDERING INFORMATION								
Temp. Range	Part Number								
-40 °C to 125 °C	10 pin miniQFN	DG9636EN-T1-E4							
-40 °C to 85 °C	10 pin miniQFN	DG9636DN-T1-E4							

#### Note

• -40 °C to 85 °C datasheet limits apply.

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25 °C, unless otherwise noted)									
Parameter	Limit	Unit							
V+ to GND	14	V							
Digital Inputs <sup>a</sup> , V <sub>S</sub> , V <sub>D</sub>	(V+) +0.3 or 30 mA, whichever occurs first	V							
Continuous Current (Any Terminal)		30	mA						
Peak Current, S or D (Pulsed 1 ms, 10 % Duty	Cycle)	100	IIIA						
Storage Temperature		-65 to 150	°C						
Power Dissipation (Package) <sup>b</sup>	10 pin miniQFN <sup>c, d</sup>	208	mW						
Thermal Resistance (Package) <sup>b</sup>	10 pin miniQFN	357	°C/W						

#### **Notes**

- a. Signals on SX, DX, or AX exceeding V+ or V- will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
- b. All leads welded or soldered to PC board.
- c. Derate 2.6 mW/°C above 70 °C.
- d. Manual soldering with iron is not recommended for leadless components. The miniQFN-10 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper lip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

SPECIFICATIONS	SPECIFICATIONS									
_		Test Conditions		_	-40 °C t	o 125 °C	-40 °C to 85 °C			
Parameter	Symbol	Unless Otherwise Specified $V+ = 12 \text{ V}, V_{A0, A1} = 1.65 \text{ V}, 0.5 \text{ V}^a$	Temp. <sup>b</sup>	Typ. <sup>c</sup>	Min. <sup>d</sup>	Max. d	Min. d	Max. d	Unit	
Analog Switch										
Analog Signal Range e	V <sub>ANALOG</sub>		Full	ı	-	12	ı	12	>	
On-Resistance	Basis	$I_S = 1 \text{ mA}, V_D = +11.3 \text{ V}$	Room	83	-	110	ı	110		
OII-I lesistarice	R <sub>DS(on)</sub>	ig = 1 111A, VD = +11.5 V	Full	1	-	140	ı	125		
On-Resistance Match	AD	I <sub>S</sub> = 1 mA, V <sub>D</sub> = +11.3 V	Room	2	-	4	-	4	Ω	
On-nesistance Match	$\Delta R_{on}$	$I_S = I IIIA, V_D = +II.3 V$	Full	-	-	9	-	6	5.2	
O. Barislana Flatara	В	I <sub>S</sub> = 1 mA, V <sub>D</sub> = 0.7 V, 6.5 V, 11.3 V	Room	33	=.	45	-	45		
On-Resistance Flatness	R <sub>FLATNESS</sub>	$I_S = I IIIA, V_D = 0.7 V, 0.3 V, II.3 V$	Full	-	-	55	-	50		
			Room	± 0.01	-1	1	-1	1		
Switch Off	I <sub>S(off)</sub>	'S(off)	V+ = 12 V,	Full	-	-18	18	-2	2	
Leakage Current	,	$V_D = 1 \text{ V/11 V}, V_S = 11 \text{ V/1 V}$	Room	± 0.01	-1	1	-1	1	nA	
	I <sub>D(off)</sub>		Full	-	-18	18	-2	2	ΠA	
Channel On		V+ = 12 V,	Room	± 0.01	-1	1	-1	1		
Leakage Current	I <sub>D(on)</sub>	$V_D = V_S 11 V/1 V$	Full	-	-18	18	-2	2		
Digital Control										
Input Current, V <sub>IN</sub> Low	I <sub>IL</sub>	V <sub>AX</sub> = 0.5 V	Full	0.005	-0.1	0.1	-0.1	0.1		
Input Current, V <sub>IN</sub> High	I <sub>IH</sub>	V <sub>AX</sub> = 1.65 V	Full	0.005	-0.1	0.1	-0.1	0.1	μA	
Input Capacitance e	C <sub>IN</sub>	f = 1 MHz	Room	3	-	-	ı	-	pF	

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SPECIFICATIONS									
_		Test Conditions	_ h		-40 °C to 125 °C		-40 °C to 85 °C		
Parameter	Symbol	Unless Otherwise Specified $V+ = 12 \text{ V}, V_{A0, A1} = 1.65 \text{ V}, 0.5 \text{ V}^a$	Temp. <sup>b</sup>	Typ. <sup>c</sup>	Min. d	Max. d	Min. d	Max. d	Unit
Dynamic Characteristic	s								
Turn-On Time	ton		Room	30	-	70	ı	70	
Turn-Ori Time	Lon		Full	-	-	90	ı	80	
Turn-Off Time	t <sub>off</sub>	$R_L = 300 \Omega, C_L = 35 pF$	Room	15	-	55	ı	55	ns
rum-on nine	Loff	see figure 1, 2	Full	-	-	75	ı	65	115
Break-Before-Make	+		Room	15	5	1	5	-	
Dreak-Delore-Iviake	t <sub>BBM</sub>		Full	-	2	-	2	-	
Charge Injection e	$Q_{INJ}$	$V_g = 0 \text{ V}, R_g = 0 \Omega, C_L = 1 \text{ nF}$	Room	23.5	-	-	-	-	рС
Off Isolation e	OIRR	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 10 MHz$	Room	-58	=.	-	-	-	dB
Bandwidth <sup>e</sup>	BW	$R_L = 50 \Omega$	Room	720	-	-	-	-	MHz
Channel-to-Channel Crosstalk <sup>e</sup>	X <sub>TALK</sub>	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 10 MHz$	Room	-67	-	-	-	-	dB
Dynamic Characteristic	s								
Source Off Capacitance <sup>e</sup>	C <sub>S(off)</sub>	f = 1 MHz	Room	2	-	-	-	-	~F
Channel On Capacitance <sup>e</sup>	C <sub>D(on)</sub>	T = 1 MHZ	Room	7.7	-	-	-	-	pF
Total Harmonic Distortion <sup>e</sup>	THD	Signal = 1 $V_{RMS}$ , 20 Hz to 20 kHz, $R_L = 600 \Omega$	Room	0.01	-	-	-	-	%
Power Supplies								•	
Dawar Cumply Cumpt	l+		Room	0.001	-	0.5	-	0.5	
Power Supply Current	I+	$V_{IN} = 0 \text{ V, or V+}$	Full	-	-	1	-	1	
Cround Current		v <sub>IN</sub> = 0 v, or v+	Room	-0.001	-0.5	-	-0.5	-	μΑ
Ground Current	I <sub>GND</sub>		Full	-	-1	-	-1	-	

SPECIFICATIONS	SPECIFICATIONS										
_		Test Conditions			-40 °C t	o 125 °C	-40 °C to 85 °C				
Parameter	Symbol	Unless Otherwise Specified $V+ = 5 V$ , $V_{A0, A1} = 1.4 V$ , $0.5 V$ a	Temp. <sup>b</sup>	Typ. <sup>c</sup>	Min. d	Max. d	Min. d	Max. d	Unit		
Analog Switch											
Analog Signal Range e	V <sub>ANALOG</sub>		Full	-	-	5	-	5	V		
On-Resistance	В		Room	120	-	170	-	170			
On-nesistance	R <sub>DS(on)</sub>	$I_S = 1 \text{ mA}, V_D = +3.5 \text{ V}$	Full	-	-	250	-	200	Ω		
On-Resistance Match	$\Delta R_{on}$	$I_S = I IIIA, V_D = +3.5 V$	Room	3	-	5	-	5			
			Full	-	-	12	-	10			
	l		Room	± 0.01	-1	1	-1	1			
Switch Off	I <sub>S(off)</sub>	$V_{+} = 5.5 \text{ V},$ $V_{D} = 1 \text{ V}/4.5 \text{ V}, V_{S} = 4.5 \text{ V}/1 \text{ V}$	Full	-	-18	18	-2	2			
Leakage Current	1		Room	± 0.01	-1	1	-1	1	nA		
	I <sub>D(off)</sub>		Full	-	-18	18	-2	2	IIA		
Channel On	,	$V+ = 5.5 \text{ V}, V_S = V_D = 1 \text{ V}/4.5 \text{ V}$	Room	± 0.01	-1	1	-1	1			
Leakage Current	I <sub>D(on)</sub>	$v + = 5.5 \text{ v}, v_S = v_D = 1 \text{ v}/4.5 \text{ v}$	Full	-	-18	18	-2	2			
Digital Control											
Input Current, V <sub>IN</sub> Low	ΙL	V <sub>AX</sub> = 0.5 V	Full	0.005	-0.1	0.1	-0.1	0.1			
Input Current, V <sub>IN</sub> High	l <sub>Η</sub>	V <sub>AX</sub> = 1.4 V	Full	0.005	-0.1	0.1	-0.1	0.1	μA		
Input Capacitance	C <sub>IN</sub>	f = 1 MHz	Room	3	-	-	-	-	pF		



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SPECIFICATIONS	SPECIFICATIONS										
_		Test Conditions			-40 °C t	o 125 °C	-40 °C to 85 °C				
Parameter	Symbol	Unless Otherwise Specified $V+=5 V$ , $V_{A0, A1}=1.4 V$ , $0.5 V$ a	Temp. <sup>b</sup>	Typ. <sup>c</sup>	Min. d	Max. d	Min. d	Max. d	Unit		
Dynamic Characteristics											
Turn-On Time	t <sub>on</sub>		Room	55	-	-	-	-			
Turri-Ori Time	Lon		Full	-	-	-	-	-			
Turn-Off Time	t <sub>off</sub>	$R_L = 300 \Omega, C_L = 35 pF$	Room	30	-	-	-	-	ns		
Turri-On Time	Loff	see figure 1, 2	Full	-	-	-	-	-	115		
Break-Before-Make-Time	t		Room	36	-	-	-	-			
Dieak-Deloie-Wake-Time	t <sub>BMM</sub>		Full	-	-	-	-	-			
Charge Injection e	$Q_{INJ}$	$C_L = 1 \text{ nF}, R_{GEN} = 0 \Omega, V_{GEN} = 0 V$	Full	10	-	-	-	-	рC		
Off-Isolation e	OIRR	$f = 10 \text{ MHz}, R_1 = 50 \Omega, C_1 = 5 \text{ pF}$	Room	-58	-	-	-	-	dB		
Crosstalk <sup>e</sup>	$X_{TALK}$	1 = 10 (γιτι2, τις = 30 32, Θς = 3 βι	Room	-68	-	-	-	-	QD.		
Bandwidth <sup>e</sup>	BW	$R_L = 50 \Omega$	Room	610	-	-	-	-	MHz		
Total Harmonic Distortion <sup>e</sup>	THD	Signal = 1 $V_{RMS}$ , 20 Hz to 20 kHz, $R_L = 600 \Omega$	Room	2.2	-	-	-	-	%		
Source Off Capacitance e	C <sub>S(off)</sub>			2.1	-	-	-	-			
Channel On Capacitance <sup>e</sup>	C <sub>D(on)</sub>	f = 1 MHz	Room	8.1	-	-	-	-	pF		
Power Supplies											
Power Supply Current	l+		Room	0.001	-	0.5	-	0.5			
i ower Supply Current	I+ 	$V_{IN} = 0 \text{ V, or V+}$	Full	-	-	1	-	1	μA		
Ground Current	laa	V <sub>IN</sub> = 0 V, 01 V+	Room	-0.001	-0.5	-	-0.5	-	μΑ		
Ground Current	I <sub>GND</sub>		Full	-	-1	-	-1	-			

SPECIFICATIONS	SPECIFICATIONS										
		Test Conditions		-40 °C t	o 125 °C	-40 °C	to 85 °C				
Parameter	Symbol	Unless Otherwise Specified V+ = 3 V, V <sub>A0, A1</sub> = 1.4 V, 0.5 V <sup>a</sup>	Temp.b	Typ. <sup>c</sup>	Min. <sup>d</sup>	Max. d	Min. d	Max. d	Unit		
Analog Switch											
Analog Signal Range e	V <sub>ANALOG</sub>		Full	-	-	3	-	3	V		
On-Resistance	B-ac		Room	200	-	245	-	245			
OII-Hesistance	R <sub>DS(on)</sub>	$I_S = 1 \text{ mA}, V_D = +1.5 \text{ V}$	Full	-	-	325	-	290	Ω		
On-Resistance Match	ΔR <sub>on</sub>	IS = 1 IIIM, VD = +1.5 V	Room	5	-	6	-	6	22		
			Full	-	-	13	-	11			
	I <sub>S(off)</sub>		Room	± 0.01	-1	1	-1	1			
Switch Off Leakage Current		<sup>I</sup> S(off)	V+ = 3.3 V, V- = 0 V	Full	-	-18	18	-2	2		
(for 16 pin miniQFN)	1	$V_D = 1 \text{ V/3 V}, V_S = 3 \text{ V/1 V}$	Room	± 0.01	-1	1	-1	1			
	I <sub>D(off)</sub>		Full	-	-18	18	-2	2	nA		
Channel On		V+ = 3.3 V, V- = 0 V,	Room	± 0.01	-1	1	-1	1			
Leakage Current (for 16 pin miniQFN)	I <sub>D(on)</sub>	$V_S = V_D = 1 \text{ V/3 V}$	Full	-	-18	18	-2	2			
Digital Control											
Input Current, V <sub>IN</sub> Low	ΙL	V <sub>AX</sub> = 0.5 V	Full	0.005	-0.1	0.1	-0.1	0.1			
Input Current, V <sub>IN</sub> High	I <sub>H</sub>	V <sub>AX</sub> = 1.4 V	Full	0.005	-0.1	0.1	-0.1	0.1	μA		
Input Capacitance	C <sub>IN</sub>	f = 1 MHz	Room	3.1	-	-	-	-	рF		



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SPECIFICATIONS	SPECIFICATIONS									
		Test Conditions		_	-40 °C t	o 125 °C	-40 °C to 85 °C			
Parameter	Symbol	Unless Otherwise Specified $V+=3 V$ , $V_{A0, A1}=1.4 V$ , $0.5 V$ a	Temp.b	Typ. <sup>c</sup>	Min. <sup>d</sup>	Max. d	Min. <sup>d</sup>	Max. d	Unit	
Dynamic Characteristics										
Enable Turn-On Time	t <sub>on</sub>		Room	96	ı	-	-	-		
Lilable fulli-on fillie	ron		Full	-	-	-	-	-		
Enable Turn-Off Time	t <sub>off</sub>	$R_L = 300 \Omega, C_L = 35 pF$	Room	60	-	-	-	-	ns	
Lilable fulli-Oil fillie	чоп	see figure 1, 2	Full	-	-	-	-	-	113	
Break-Before-Make-Time	+		Room	77	ı	-	-	-		
Dieak-Deloie-Wake-Time	t <sub>BMM</sub>		Full	-	-	-	-	-		
Charge Injection e	$Q_{INJ}$	$C_L = 1 \text{ nF}, R_{GEN} = 0 \Omega, V_{GEN} = 0 V$	Full	6.6	1	-	-	-	рС	
Off-Isolation e	OIRR	$f = 10 \text{ MHz}, R_1 = 50 \Omega, C_1 = 5 \text{ pF}$	Room	-57	ı	-	-	-	dB	
Crosstalk e	$X_{TALK}$	$1 = 10 \text{ Wil 12}, \text{ H}_{L} = 30 \text{ S2}, \text{ O}_{L} = 3 \text{ pl}^{-1}$	Room	-69	ı	-	-	-	uБ	
Bandwidth <sup>e</sup>	BW	$R_L = 50 \Omega$	Room	525	1	-	-	-	MHz	
Total Harmonic Distortion <sup>e</sup>	THD	Signal = 1 $V_{RMS}$ , 20 Hz to 20 kHz, $R_L = 600 \Omega$	Room	2.2	-	-	-	-	%	
Source Off Capacitance e	C <sub>S(off)</sub>			2.1	-	-	-	-		
Channel On Capacitance <sup>e</sup>	C <sub>D(on)</sub>	f = 1 MHz	Room	8.3	-	-	=	-	pF	
Power Supplies										
Power Supply Current	I+		Room	0.001	1	0.5	-	0.5		
Fower Supply Current	I+ 	V <sub>IN</sub> = 0 V, or V+	Full	-	-	1	-	1		
Ground Current	1	V <sub>IN</sub> = 0 V, 01 V+	Room	-0.001	-0.5	-	-0.5	-	μA	
Giodila Odifetti	I <sub>GND</sub>		Full	-	-1	-	-1	-		

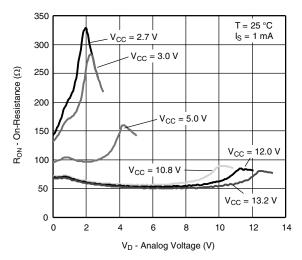
#### Notes

- a.  $V_{IN}$  = input voltage to perform proper function.
- b. Room = 25  $^{\circ}$ C, Full = as determined by the operating temperature.
- c. Typical value are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- d. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this datasheet.
- e. Guaranteed by design, not subject to production test.

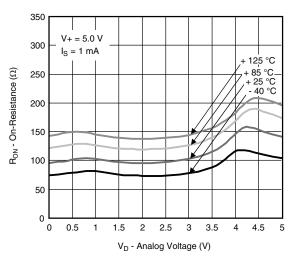
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



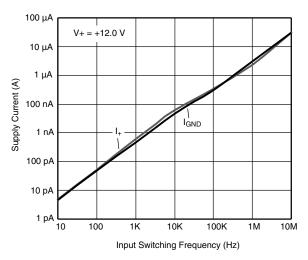
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



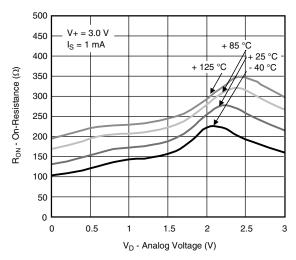
On-Resistance vs. Single Supply Voltage



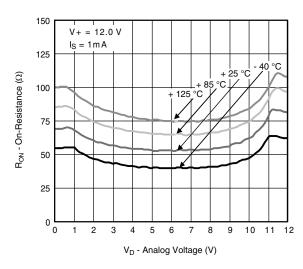
On-Resistance vs. Analog Voltage and Temperature



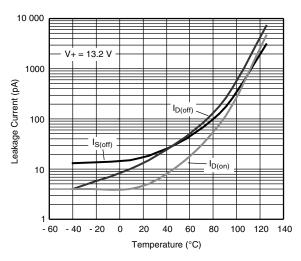
**Supply Current vs. Input Switching Frequency** 



On-Resistance vs. Analog Voltage and Temperature



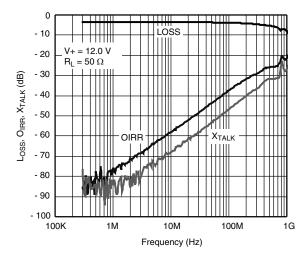
On-Resistance vs. Analog Voltage and Temperature



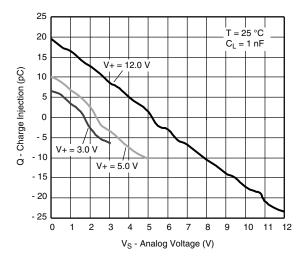
Leakage Current vs. Temperature



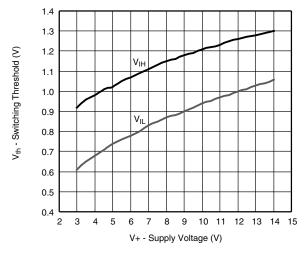
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Insertion Loss, Off-Isolation, Crosstalk vs. Frequency



Charge Injection vs. Analog voltage



Switching Threshold vs. Supply Voltage

### **TEST CIRCUITS**

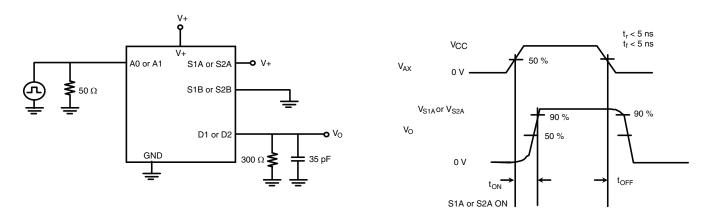


Figure 1. Enable Switching Time

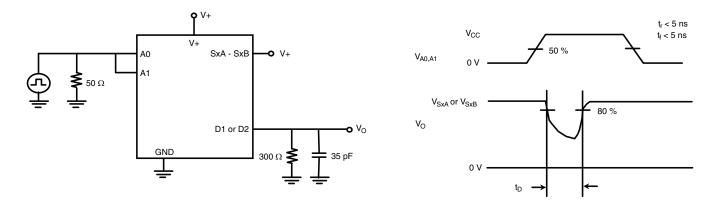


Figure 2. Break-Before-Make

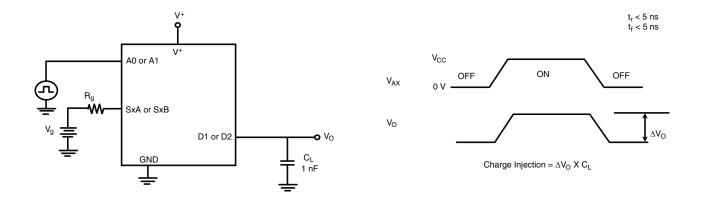


Figure 3. Charge Injection



### **TEST CIRCUITS**

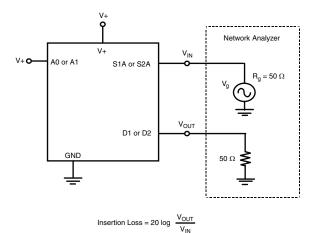


Figure 4. Insertion Loss

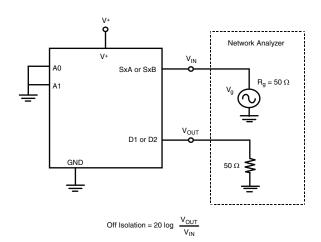


Figure 5. Off-Isolation

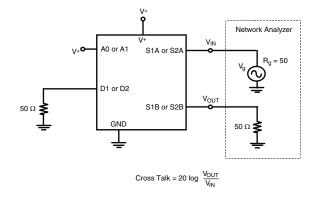


Figure 6. Crosstalk

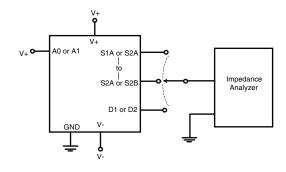


Figure 7. Source/Drain Capacitance

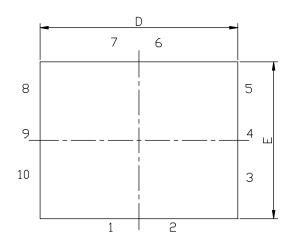
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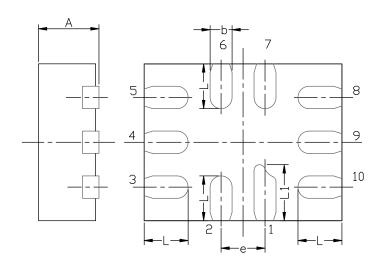


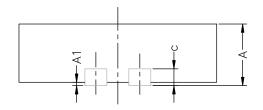
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## MINI QFN-10L CASE OUTLINE







DIM		MILLIMETERS			INCHES			
DIM	MIN.	NAM.	MAX.	MIN.	NAM.	MAX.		
Α	0.45	0.55	0.60	0.0177	0.0217	0.0236		
A1	0.00	-	0.05	0.000	-	0.002		
b	0.15	0.20	0.25	0.006	0.008	0.010		
С		0.150 or 0.127 REF <sup>(</sup>	1)		0.006 or 0.005 REF <sup>(1</sup>	)		
D	1.70	1.80	1.90	0.067	0.071	0.075		
E	1.30	1.40	1.50	0.051	0.055	0.059		
е		0.40 BSC		0.016 BSC				
L	0.35	0.40	0.45	0.014	0.016	0.018		
L1	0.45	0.50	0.55	0.0177	0.0197	0.0217		

#### Note

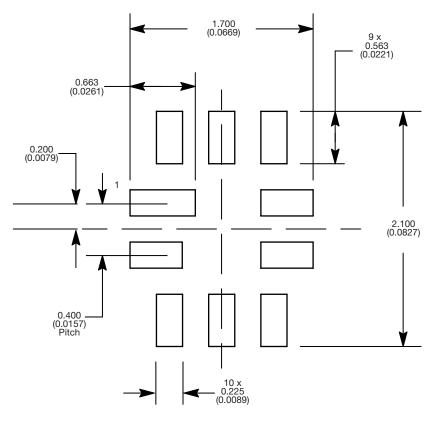
 $^{(1)}$  The dimension depends on the leadframe that assembly house used.

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### **RECOMMENDED MINIMUM PADS FOR MINI QFN 10L**



Mounting Footprint Dimensions in mm (inch)

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